

# SST25VF080B

# 8-Mbit SPI Serial Flash

# Features

- Single Voltage Read and Write Operations
   2.7V-3.6V
- Serial Interface Architecture:
  - SPI Compatible: Mode 0 and Mode 3
- High-Speed Clock Frequency:
  - Up to 66 MHz
- Superior Reliability:
  - Endurance: 100,000 Cycles (typical)
  - Greater than 100 years Data Retention
- Low-Power Consumption:
  - Active Read Current: 10 mA (typical)
- Standby Current: 5 µA (typical)
- Flexible Erase Capability:
  - Uniform 4-Kbyte sectors
  - Uniform 32-Kbyte overlay blocks
  - Uniform 64-Kbyte overlay blocks
- Fast Erase and Byte Program:
  - Chip Erase Time: 35 ms (typical)
  - Sector/Block Erase Time: 18 ms (typical)
  - Byte Program Time: 7 µs (typical)
- Auto Address Increment (AAI) Programming:
  - Decrease total chip programming time over Byte Program operations
- End of Write Detection:
  - Software polling the BUSY bit in STATUS Register
  - Busy Status readout on SO pin in AAI Mode
- Hold Pin (HOLD#):
  - Suspends a serial sequence to the memory without deselecting the device
- Write Protection (WP#):
  - Enables/Disables the Lock-Down function of the STATUS register
- Software Write Protection:
  - Write protection through Block Protection bits in STATUS register
- Temperature Range:
  - Commercial: 0°C to +70°C
  - Industrial: -40°C to +85°C
- · All devices are RoHS compliant

# Packages

 8-lead PDIP (300 mils), 8-lead SOIC (200 mils), 8-contact WSON (6 mm x 5 mm) and 16-ball XFBGA (Z-Scale<sup>™</sup>) See Figure 2-1 for pin assignments.

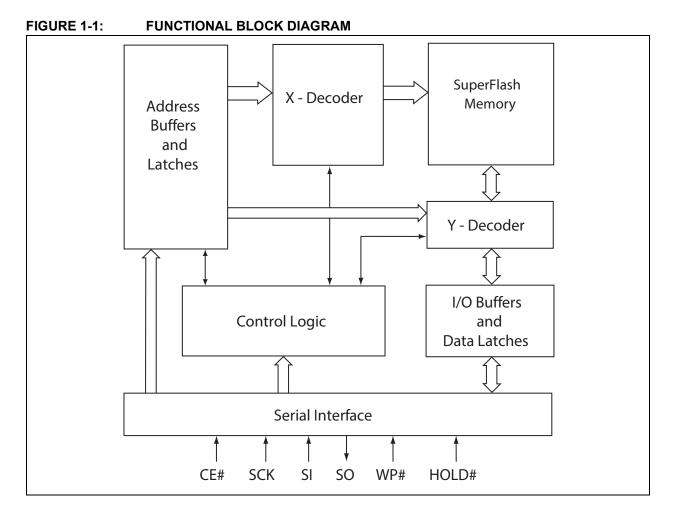
# Description

25 series Serial Flash family features a four-wire, SPI-compatible interface that allows for a low pin-count package which occupies less board space and ultimately lowers total system costs. The SST25VF080B devices are enhanced with improved operating frequency and lower power consumption. SST25VF080B SPI serial flash memories are manufactured with proprietary, high-performance CMOS SuperFlash<sup>®</sup> technology. The split-gate cell design and thick-oxide tunneling injector attain better reliability and manufacturability compared with alternate approaches.

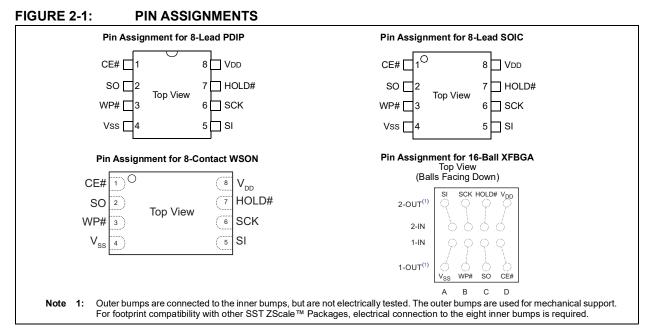
The SST25VF080B devices significantly improve performance and reliability, while lowering power consumption. The devices write (program or erase) with a single power supply of 2.7V-3.6V for SST25VF080B. The total energy consumed is a function of the applied voltage, current, and time of application. Since for any given voltage range, the SuperFlash technology uses less current to program and has a shorter erase time, the total energy consumed during any erase or program operation is less than alternative flash memory technologies.

# SST25VF080B

# 1.0 BLOCK DIAGRAM



# 2.0 PIN DESCRIPTION



# TABLE 2-1: PIN DESCRIPTION

Symbol	Pin Name	Functions	
SCK	Serial Clock	To provide the timing of the serial interface. Commands, addresses, or input data are latched on the rising edge of the clock input, while output data is shifted out on the falling edge of the clock input.	
SI	Serial Data Input	To transfer commands, addresses, or data serially into the device. Inputs are latched on the rising edge of the serial clock.	
SO	Serial Data Output	To transfer data serially out of the device. Data is shifted out on the falling edge of the serial clock. Outputs Flash busy status during AAI Programming when reconfigured as RY/BY pin. See Section 4.4.5 "End of Write Detection" for details.	
CE#	Chip Enable	The device is enabled by a high to low transition on CE#. CE# must remain low for the duration of any command sequence.	
WP#	Write-Protect	The Write-Protect (WP#) pin is used to enable/disable BPL bit in the STATUS register.	
HOLD#	Hold	To temporarily stop serial communication with SPI flash memory without resetting the device.	
Vdd	Power Supply	To provide power supply voltage:2.7V-3.6V for SST25VF080B.	
Vss	Ground		

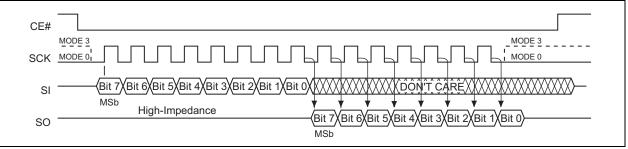
# 3.0 MEMORY ORGANIZATION

The SST25VF080B SuperFlash memory array is organized in uniform 4-Kbyte erasable sectors with 32 Kbyte overlay blocks and 64 Kbyte overlay erasable blocks.

# 4.0 DEVICE OPERATION

The SST25VF080B is accessed through the SPI (Serial Peripheral Interface) bus compatible protocol. The SPI bus consist of four control lines; Chip Enable (CE#) is used to select the device, and data is accessed through the Serial Data Input (SI), Serial Data Output (SO), and Serial Clock (SCK). The SST25VF080B supports both Mode 0 (0,0) and Mode 3 (1,1) of SPI bus operations. The difference between the two modes, as shown in Figure 4-1, is the state of the SCK signal when the bus master is in Stand-by mode and no data is being transferred. The SCK signal is low for Mode 0 and SCK signal is high for Mode 3. For both modes, the Serial Data In (SI) is sampled at the rising edge of the SCK clock signal and the Serial Data Output (SO) is driven after the falling edge of the SCK clock signal.





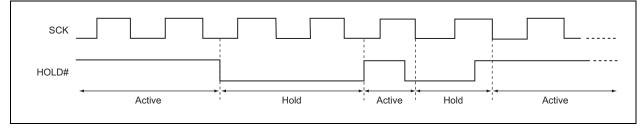
# 4.1 Hold Operation

The HOLD# pin is used to pause a serial sequence underway with the SPI flash memory without resetting the clocking sequence. To activate the HOLD# mode, CE# must be in active-low state. The HOLD# mode begins when the SCK active-low state coincides with the falling edge of the HOLD# signal. The HOLD mode ends when the HOLD# signal's rising edge coincides with the SCK active-low state.

If the falling edge of the HOLD# signal does not coincide with the SCK active-low state, then the device enters Hold mode when the SCK next reaches the active-low state. Similarly, if the rising edge of the HOLD# signal does not coincide with the SCK active-low state, then the device exits in Hold mode when the SCK next reaches the active-low state. See Figure 4-2 for Hold Condition waveform. Once the device enters Hold mode, SO will be in high-impedance state while SI and SCK can be VIL or VIH.

If CE# is driven active high during a Hold condition, it resets the internal logic of the device. As long as HOLD# signal is low, the memory remains in the Hold condition. To resume communication with the device, HOLD# must be driven active high, and CE# must be driven active-low. See Figure 7-3 for Hold timing.





# 4.2 Write Protection

SST25VF080B provides software write protection. The Write-Protect pin (WP#) enables or disables the lockdown function of the STATUS Register. The Block Protection bits (BP3, BP2, BP1, BP0, and BPL) in the STA-TUS register provide Write protection to the memory array and the STATUS register. See Table 4-3 for the Block Protection description.

# 4.2.1 WRITE PROTECTION PIN (WP#)

The Write-Protect (WP#) pin enables the lock-down function of the BPL bit (bit 7) in the STATUS Register. When WP# is driven low, the execution of the Write STATUS Register (WRSR) instruction is determined by the value of the BPL bit (see Table 4-1). When WP# is high, the lock-down function of the BPL bit is disabled.

TABLE 4-1: CONDITIONS TO EXECUTE WRITE STATUS REGISTER (WRSR) INSTRUCTION
---

WP#	BPL	Execute WRSR Instructions
L	1	Not Allowed
L	0	Allowed
Н	Х	Allowed

### 4.3 STATUS Register

The software STATUS Register provides status on whether the flash memory array is available for any read or write operation, whether the device is Write enabled, and the state of the Memory Write-protected. During an internal erase or program operation, the STATUS Register may be read only to determine the completion of an operation in progress. Table 4-2 describes the function of each bit in the software STA-TUS Register.

Bit	Name	Function	Default at Power-up	Read/Write
0	BUSY	<ul><li>1 = Internal Write operation is in progress</li><li>0 = No internal Write operation is in progress</li></ul>	0	R
1	WEL	<ul><li>1 = Device is memory Write enabled</li><li>0 = Device is not memory Write enabled</li></ul>	0	R
2	BP0	Indicate current level of block write protection (See Table 4-3)	1	R/W
3	BP1	Indicate current level of block write protection (See Table 4-3)	1	R/W
4	BP2	Indicate current level of block write protection (See Table 4-3)	1	R/W
5	BP3	Indicate current level of block write protection (See Table 4-3)	0	R/W
6	AAI	Auto Address Increment Programming status 1 = AAI programming mode 0 = Byte Program mode	0	R
7	BPL	1 = BP3, BP2, BP1, BP0 are read-only bits 0 = BP3, BP2, BP1, BP0 are read/writable	0	R/W

# TABLE 4-2: SOFTWARE STATUS REGISTER

# 4.3.1 BUSY

The BUSY bit determines whether there is an internal Erase or Program operation in progress. A '1' for the BUSY bit indicates the device is busy with an operation in progress. A '0' indicates the device is ready for the next valid operation.

# 4.3.2 WRITE ENABLE LATCH (WEL)

The Write Enable Latch bit indicates the status of the internal memory Write Enable Latch. If the Write Enable Latch bit is set to '1', it indicates the device is Write enabled. If the bit is set to '0' (reset), it indicates the device is not write enabled and does not accept any

memory write (program/erase) commands. The Write Enable Latch bit is automatically reset under the following conditions:

- Power-up
- Write Disable (WRDI) instruction completion
- · Byte Program instruction completion
- Auto Address Increment (AAI) programming is completed or reached its highest unprotected memory address
- Sector Erase instruction completion
- · Block Erase instruction completion
- Chip Erase instruction completion
- Write STATUS Register instructions

# 4.3.3 AUTO ADDRESS INCREMENT (AAI)

The Auto Address Increment Programming Status bit provides status on whether the device is in AAI programming mode or Byte-Program mode. The default at power up is Byte-Program mode.

# 4.3.4 BLOCK PROTECTION (BP3,BP2, BP1, BP0)

The Block Protection (BP3, BP2, BP1, BP0) bits define the size of the memory area, as defined in Table 4-3, to be software protected against any memory write (program or erase) operation. The Write STATUS Register (WRSR) instruction is used to program the BP3, BP2, BP1 and BP0 bits as long as WP# is high or the Block Protect Lock (BPL) bit is '0'. Chip Erase can only be executed if Block Protection bits are all '0'. After powerup, BP3, BP2, BP1 and BP0 are set to '1'.

### 4.3.5 BLOCK PROTECTION LOCK-DOWN (BPL)

WP# pin driven low (VIL), enables the Block Protection Lock Down (BPL) bit. When BPL is set to '1', it prevents any further alteration of the BPL, BP3, BP2, BP1, and BP0 bits. When the WP# pin is driven high (VIH), the BPL bit has no effect and its value is "don't care". After power-up, the BPL bit is reset to '0'.

TABLE 4-3:	SOFTWARE STATUS REGISTER BLOCK PROTECTION FOR SST25VF080B $^{()}$

Protection Level	STATUS Register Bit			Protected Memory Address	
Protection Level	BP3	BP2	BP1	BP0	8 Mbits
None	Х	0	0	0	None
Upper 1/16	Х	0	0	1	F0000H-FFFFFH
Upper 1/8	Х	0	1	0	E0000H-FFFFH
Upper 1/4	Х	0	1	1	C0000H-FFFFFH
Upper 1/2	Х	1	0	0	80000H-FFFFFH
All Blocks	Х	1	0	1	00000H-FFFFH
All Blocks	Х	1	1	0	00000H-FFFFH
All Blocks	Х	1	1	1	00000H-FFFFH

Note 1: X = "Don't care" (RESERVED) default is '0'.

2: Default at power-up for BP2, BP1, and BP0 is '111'. (All Blocks Protected)

# 4.4 Instructions

Instructions are used to read, write (Erase and Program), and configure the SST25VF080B. The instruction bus cycles are 8 bits each for commands (Op Code), data, and addresses. Prior to executing any Byte Program, Auto Address Increment (AAI) programming, Sector Erase, Block Erase, Write STATUS Register, or Chip Erase instructions, the Write Enable (WREN) instruction must be executed first. The complete list of instructions is provided in Table 4-4. All instructions are synchronized off a high to low transition of CE#. Inputs will be accepted on the rising edge of SCK starting with the most significant bit. CE# must be driven low before an instruction is entered and must be driven high after the last bit of the instruction has been shifted in (except for Read, Read-ID, and Read STA-TUS Register instructions). Any low to high transition on CE#, before receiving the last bit of an instruction bus cycle, will terminate the instruction in progress and return the device to standby mode. Instruction commands (Op Code), addresses, and data are all input from the most significant bit (MSb) first.

Instruction	Description	Op Code Cycle <sup>(1)</sup>	Address Cycle(s) <sup>(2)</sup>	Dummy Cycle(s)	Data Cycle(s)
Read	Read Memory	0000 0011b (03H)	3	0	1 to ∞
High-Speed Read	Read Memory at higher speed	0000 1011b (0BH)	3	1	1 to ∞
4-Kbyte Sector Erase <sup>(3)</sup>	Erase 4 Kbyte of memory array	0010 0000b (20H)	3	0	0
32-Kbyte Block Erase <sup>(4)</sup>	Erase 32 Kbyte block of memory array	0101 0010b (52H)	3	0	0
64-Kbyte Block Erase <sup>(5)</sup>	Erase 64 Kbyte block of memory array	1101 1000b (D8H)	3	0	0
Chip-Erase	Erase Full Memory Array	0110 0000b (60H) or 1100 0111b (C7H)	0	0	0
Byte Program	To Program One Data Byte	0000 0010b (02H)	3	0	1
AAI Word Program <sup>(6)</sup>	Auto Address Increment Programming	1010 1101b (ADH)	3	0	2 to ∞
RDSR <sup>(7)</sup>	Read STATUS Register	0000 0101b (05H)	0	0	1 to ∞
EWSR	Enable Write STATUS Register	0101b 0000b (50H)	0	0	0
WRSR	Write STATUS Register	0000 0001b (01H)	0	0	1
WREN	Write Enable	0000 0110b (06H)	0	0	0
WRDI	Write Disable	0000 0100b (04H)	0	0	0
RDID <sup>(8)</sup>	Read-ID	1001 0000b (90H) or 1010 1011b (ABH)	3	0	1 to ∞
JEDEC-ID	JEDEC ID read	1001 1111b (9FH)	0	0	3 to ∞
EBSY	Enable SO to output RY/BY# status during AAI programming	0111 0000b (70H)	0	0	0
DBSY	Disable SO as RY/BY# status during AAI programming	1000 0000b (80H)	0	0	0

TABLE 4-4: DEVICE OPERATION INSTRUCTION

### TABLE 4-4: DEVICE OPERATION INSTRUCTION

Instruction Description	Op Code Cycle <sup>(1)</sup>	Address Cycle(s) <sup>(2)</sup>	Dummy Cycle(s)	Data Cycle(s)	
-------------------------	------------------------------	------------------------------------	-------------------	------------------	--

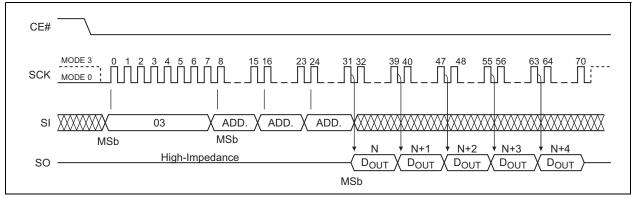
**Note 1:** One bus cycle is eight clock periods.

- 2: Address bits above the most significant bit of each density can be VIL or VIH.
- **3:** 4-Kbyte Sector Erase addresses: use AMS-A12, remaining addresses are "don't care" but must be set either at VIL or VIH.
- 4: 32-Kbyte Block Erase addresses: use AMS-A15, remaining addresses are "don't care" but must be set either at VIL or VIH.
- **5:** 64-Kbyte Block Erase addresses: use AMS-A16, remaining addresses are "don't care" but must be set either at VIL or VIH.
- **6:** To continue programming to the next sequential address location, enter the 8-bit command, ADH, followed by 2 bytes of data to be programmed. Data Byte 0 will be programmed into the initial address [A23-A1] with A0 = 0, Data Byte 1 will be programmed into the initial address [A23-A1] with A0 = 1.
- 7: The Read STATUS Register is continuous with ongoing clock cycles until terminated by a low-to-high transition on CE#.
- 8: Manufacturer's ID is read with A0 = 0, and Device ID is read with A0 = 1. All other address bits are 00H. The Manufacturer's ID and device ID output stream is continuous until terminated by a low-to-high transition on CE#.

#### 4.4.1 READ (25 MHZ)

The Read instruction, 03H, supports up to 25 MHz Read. The device outputs the data starting from the specified address location. The data output stream is continuous through all addresses until terminated by a low to high transition on CE#. The internal address pointer will automatically increment until the highest memory address is reached. Once the highest memory address is reached, the address pointer will automatically increment to the beginning (wrap-around) of the address space. Once the data from address location FFFFFH has been read, the next output will be from address location 00000H.

The Read instruction is initiated by executing an 8-bit command, 03H, followed by address bits [A23-A0]. CE# must remain active-low for the duration of the Read cycle. See Figure 4-3 for the Read sequence.



# FIGURE 4-3: READ SEQUENCE

through all addresses until terminated by a low to high transition on CE#. The internal address pointer will

automatically increment until the highest memory

address is reached. Once the highest memory address

is reached, the address pointer will automatically incre-

ment to the beginning (wrap-around) of the address

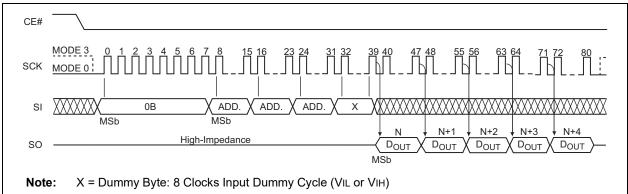
space. Once the data from address location FFFFH

has been read, the next output will be from address

# 4.4.2 HIGH-SPEED READ (66 MHZ)<sup>1</sup>

The High-Speed Read instruction, supporting up to 66 MHz Read, is initiated by executing an 8-bit command, 0BH, followed by address bits [A23-A0] and a dummy byte. CE# must remain active-low for the duration of the High-Speed Read cycle. See Figure 4-4 for the High-Speed Read sequence.

Following a dummy cycle, the High-Speed Read instruction outputs the data starting from the specified address location. The data output stream is continuous



location 00000H.

### 4.4.3 BYTE PROGRAM

The Byte Program instruction programs the bits in the selected byte to the desired data. The selected byte must be in the erased state (FFH) when initiating a Program operation. A Byte Program instruction applied to a protected memory area will be ignored.

Prior to any Write operation, the Write Enable (WREN) instruction must be executed. CE# must remain active-low for the duration of the Byte Program instruc-

tion. The Byte Program instruction is initiated by executing an 8-bit command, 02H, followed by address bits [A23-A0]. Following the address, the data is input in order from MSb (bit 7) to LSb (bit 0). CE# must be driven high before the instruction is executed. The user may poll the BUSY bit in the software STATUS Register or wait TBP for the completion of the internal self-timed Byte Program operation. See Figure 4-5 for the Byte Program sequence.

#### FIGURE 4-5: BYTE PROGRAM SEQUENCE CE# SCK MODE 0 02 ADD. ADD ADD. SI DIN MSb MSb LSb MSb SO High-Impedance

### 4.4.4 AUTO ADDRESS INCREMENT (AAI) WORD PROGRAM

The AAI program instruction allows multiple bytes of data to be programmed without re-issuing the next sequential address location. This feature decreases total programming time when multiple bytes or entire memory array is to be programmed. An AAI Word program instruction pointing to a protected memory area will be ignored. The selected address range must be in the erased state (FFH) when initiating an AAI Word Program operation. While within AAI Word programming sequence, only the following instructions are valid: for software end of write detection-AAI Word (ADH), WRDI (04H), and RDSR (05H); for hardware end of write detection—AAI Word (ADH) and WRDI (04H). There are three options to determine the completion of each AAI Word program cycle: hardware detection by reading the Serial Output, software detection by polling the BUSY bit in the software STATUS Register, or wait TBP. Refer to Section 4.4.5 "End of Write Detection" for details.

Prior to any write operation, the Write Enable (WREN) instruction must be executed. Initiate the AAI Word Program instruction by executing an 8-bit command, ADH, followed by address bits [A23-A0]. Following the addresses, two bytes of data are input sequentially, each one from MSb (Bit 7) to LSb (Bit 0). The first byte of data (D0) is programmed into the initial address [A23-A1] with A0 = 0, the second byte of Data (D1) is programmed into the initial address [A23-A1] with A0 = 0, the second byte of Data (D1) is programmed into the initial address [A23-A1] with A0 = 1. CE# must be driven high before executing the AAI Word Program instruction. Check the Busy status before entering the next valid command. Once the device indicates it is no longer busy, data for the next two sequential addresses may be programmed, followed by the next two, and so on.

When programming the last desired word, or the highest unprotected memory address, check the busy status using either the hardware or software (RDSR instruction) method to check for program completion. Once programming is complete, use the applicable method to terminate AAI. If the device is in Software End of Write Detection mode, execute the Write-Disable (WRDI) instruction, 04H. If the device is in AAI Hardware End of Write Detection mode, execute the Write Disable (WRDI) instruction, 04H, followed by the 8-bit DBSY command, 80H. There is no wrap mode during AAI programming once the highest unprotected memory address is reached. See Figure 4-8 and Figure 4-9 for the AAI Word programming sequence.

# 4.4.5 END OF WRITE DETECTION

There are three methods to determine completion of a program cycle during AAI Word programming: hard-ware detection by reading the Serial Output, software detection by polling the BUSY bit in the Software STA-TUS Register, or wait TBP. The Hardware End of Write detection method is described in the section below.

# 4.4.6 HARDWARE END OF WRITE DETECTION

The Hardware End of Write detection method eliminates the overhead of polling the BUSY bit in the Software STATUS Register during an AAI Word program operation. The 8-bit command, 70H, configures the Serial Output (SO) pin to indicate Flash Busy status during AAI Word programming. (see Figure 4-6) The 8-bit command, 70H, must be executed prior to initiating an AAI Word Program instruction. Once an internal programming operation begins, asserting CE# will immediately drive the status of the internal flash status on the SO pin. A '0' indicates the device is busy and a '1' indicates the device is ready for the next instruction. De-asserting CE# will return the SO pin to tri-state. While in AAI and Hardware End of Write detection mode, the only valid instructions are AAI Word (ADH) and WRDI (04H).

To exit AAI Hardware End of Write detection, first execute WRDI instruction, 04H, to reset the Write Enable Latch bit (WEL = 0) and AAI bit. Then execute the 8-bit DBSY command, 80H, to disable RY/BY# status during the AAI command. See Figure 4-7 and Figure 4-8.

# FIGURE 4-6:

#### ENABLE SO AS HARDWARE RY/BY# DURING AAI PROGRAMMING

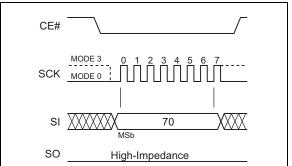
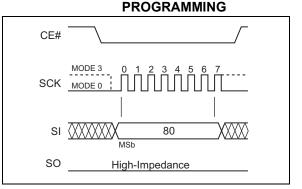


FIGURE 4-7:

DISABLE SO AS HARDWARE RY/BY# DURING AAI



<sup>© 2005-2020</sup> Microchip Technology Inc.



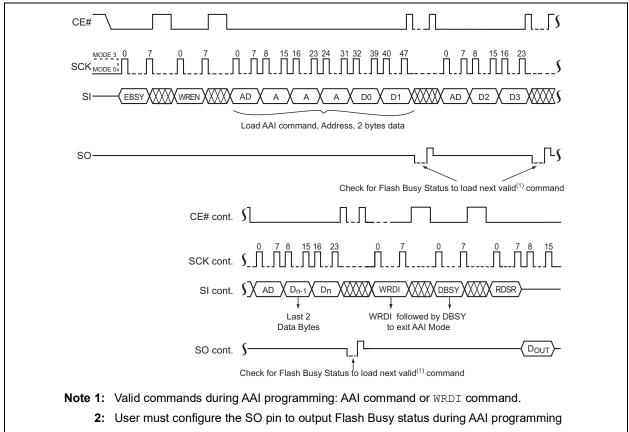
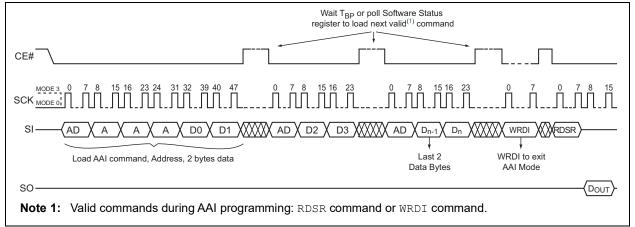


FIGURE 4-9: AUTO ADDRESS INCREMENT (AAI) WORD PROGRAM SEQUENCE WITH SOFTWARE END OF WRITE DETECTION

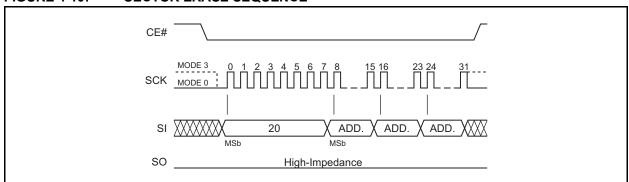


# 4.4.7 4-KBYTE SECTOR ERASE

The Sector Erase instruction clears all bits in the selected 4-Kbyte sector to FFH. A Sector Erase instruction applied to a protected memory area will be ignored. Prior to any Write operation, the Write Enable (WREN) instruction must be executed. CE# must remain active-low for the duration of any command sequence. The Sector Erase instruction is initiated by executing an 8-bit command, 20H, followed by address bits [A23-

FIGURE 4-10: SECTOR ERASE SEQUENCE

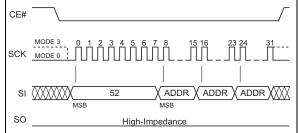
Ao]. Address bits [AMS-A12] (AMS = Most Significant address) are used to determine the sector address (SAX), remaining address bits can be VIL or VIH. CE# must be driven high before the instruction is executed. The user may poll the BUSY bit in the Software STA-TUS Register or wait TSE for the completion of the internal self-timed Sector Erase cycle. See Figure 4-10 for the Sector Erase sequence.



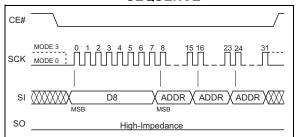
# 4.4.8 32-KBYTE AND 64-KBYTE BLOCK ERASE

The 32-Kbyte Block Erase instruction clears all bits in the selected 32 Kbyte block to FFH. A Block Erase instruction applied to a protected memory area will be ignored. The 64-Kbyte Block-Erase instruction clears all bits in the selected 64 Kbyte block to FFH. A Block Erase instruction applied to a protected memory area will be ignored. Prior to any Write operation, the Write Enable (WREN) instruction must be executed. CE# must remain active-low for the duration of any command sequence. The 32-Kbyte Block Erase instruction is initiated by executing an 8-bit command, 52H, followed by address bits [A23-A0]. Address bits [AMS-A15] (AMS = Most Significant Address) are used to determine block address (BAx), remaining address bits can be VIL or VIH. CE# must be driven high before the instruction is executed. The 64-Kbyte Block Erase instruction is initiated by executing an 8-bit command D8H, followed by address bits [A23-A0]. Address bits [AMS-A15] are used to determine block address (BAx), remaining address bits can be VIL or VIH. CE# must be driven high before the instruction is executed. The user may poll the BUSY bit in the Software STATUS Register or wait TBE for the completion of the internal selftimed 32-Kbyte Block Erase or 64-Kbyte Block Erase cycles. See Figure 4-11 and Figure 4-12 for the 32-Kbyte Block Erase and 64-Kbyte Block Erase sequences.





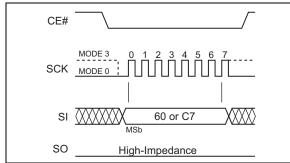
# FIGURE 4-12: 64-KBYTE BLOCK ERASE SEQUENCE



# 4.4.9 CHIP ERASE

The Chip Erase instruction clears all bits in the device to FFH. A Chip Erase instruction will be ignored if any of the memory area is protected. Prior to any Write operation, the Write Enable (WREN) instruction must be executed. CE# must remain active-low for the duration of the Chip Erase instruction sequence. The Chip Erase instruction is initiated by executing an 8-bit command, 60H or C7H. CE# must be driven high before the instruction is executed. The user may poll the BUSY bit in the Software STATUS Register or wait TCE for the completion of the internal self-timed Chip Erase cycle. See Figure 4-13 for the Chip Erase sequence.

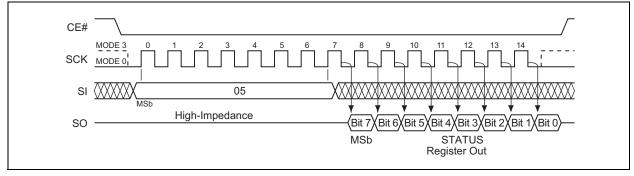
FIGURE 4-13: CHIP ERASE SEQUENCE



# 4.4.10 READ STATUS REGISTER (RDSR)

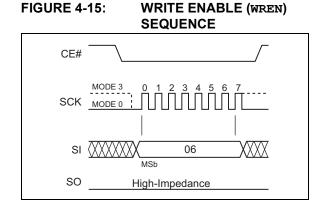
The Read STATUS Register (RDSR) instruction allows reading of the STATUS Register. The STATUS Register may be read at any time even during a write (program/ erase) operation. When a write operation is in progress, the BUSY bit may be checked before sending any new commands to assure that the new commands are properly received by the device. CE# must be driven low before the RDSR instruction is entered and remain low until the status data is read. Read STATUS Register is continuous with ongoing clock cycles until it is terminated by a low-to-high transition of the CE#. See Figure 4-14 for the RDSR instruction sequence.

### FIGURE 4-14: READ STATUS REGISTER (RDSR) SEQUENCE



#### 4.4.11 WRITE ENABLE (WREN) SEQUENCE

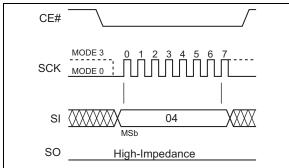
The Write Enable (WREN) instruction sets the Write-Enable Latch bit in the STATUS Register to '1' allowing Write operations to occur. The WREN instruction must be executed prior to any write (program/erase) operation. The WREN instruction may also be used to allow execution of the Write STATUS Register (WRSR) instruction; however, the Write Enable Latch bit in the STATUS Register will be cleared upon the rising edge CE# of the WRSR instruction. CE# must be driven high before the WREN instruction is executed.



### 4.4.12 WRITE DISABLE (WRDI)

The Write Disable (WRDI) instruction resets the Write-Enable-Latch bit and AAI bit to '0' disabling any new Write operations from occurring. The WRDI instruction will not terminate any programming operation in progress. Any program operation in progress may continue up to TBP after executing the WRDI instruction. CE# must be driven high before the WRDI instruction is executed.

FIGURE 4-16: WRITE DISABLE (WRDI) SEQUENCE



### 4.4.13 ENABLE WRITE STATUS REGISTER (EWSR)

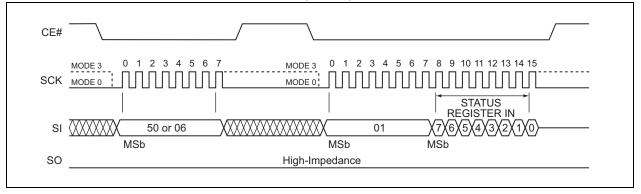
The Enable Write STATUS Register (EWSR) instruction arms the Write STATUS Register (WRSR) instruction and opens the STATUS Register for alteration. The Write STATUS Register instruction must be executed immediately after the execution of the Enable Write STATUS Register instruction. This two-step instruction sequence of the EWSR instruction followed by the WRSR instruction works like SDP (software data protection) command structure which prevents any accidental alteration of the STATUS Register values. CE# must be driven low before the EWSR instruction is entered and must be driven high before the EWSR instruction is executed.

# 4.4.14 WRITE STATUS REGISTER (WRSR)

The Write STATUS Register instruction writes new values to the BP3, BP2, BP1, BP0, and BPL bits of the STATUS Register. CE# must be driven low before the command sequence of the WRSR instruction is entered and driven high before the WRSR instruction is executed. See Figure 4-17 for EWSR or WREN and WRSR instruction sequences.

Executing the Write STATUS Register instruction will be ignored when WP# is low and BPL bit is set to '1'. When the WP# is low, the BPL bit can only be set from '0' to '1' to lock-down the STATUS Register, but cannot be reset from '1' to '0'. When WP# is high, the lockdown function of the BPL bit is disabled and the BPL, BP0, and BP1 and BP2 bits in the STATUS Register can all be changed. As long as BPL bit is set to '0' or WP# pin is driven high (VIH) prior to the low-to-high transition of the CE# pin at the end of the WRSR instruction, the bits in the STATUS Register can all be altered by the WRSR instruction. In this case, a single WRSR instruction can set the BPL bit to '1' to lock down the STATUS register as well as altering the BP0, BP1, and BP2 bits at the same time. See Table 4-1 for a summary description of WP# and BPL functions.

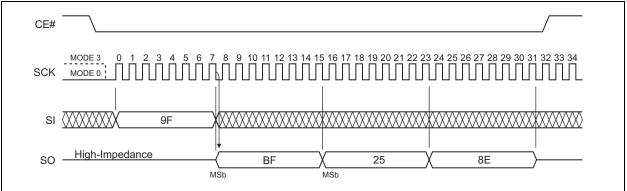




### 4.4.15 JEDEC READ-ID

The JEDEC Read-ID instruction identifies the device as SST25VF080B and the manufacturer as Microchip. The device information can be read from executing the 8-bit command, 9FH. Following the JEDEC Read-ID instruction, the 8-bit manufacturer's ID, BFH, is output from the device. After that, a 16-bit device ID is shifted out on the SO pin. Byte 1, BFH, identifies the manufacturer as Microchip. Byte 2, 25H, identifies the memory type as SPI Serial Flash. Byte 3, 8EH, identifies the device as SST25VF080B. The instruction sequence is shown in Figure 4-18. The JEDEC Read ID instruction is terminated by a low to high transition on CE# at any time during data output.





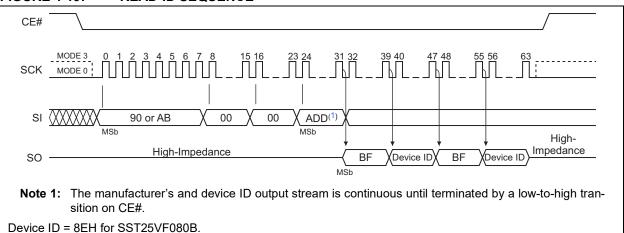
Manufacturer's ID	Device ID		
Manufacturer S ID	Memory Type	Memory Capacity	
Byte1	Byte 2	Byte 3	
BFH	25H	8EH	

#### 4.4.16 **READ-ID (RDID)**

The Read-ID (RDID) instruction identifies the devices as SST25VF080B and manufacturer as Microchip. This command is backward compatible and should be used as default device identification when multiple versions of SPI Serial Flash devices are used in a design. The device information can be read from executing an 8-bit command, 90H or ABH, followed by address bits [A23-A0]. Following the Read-ID instruction, the manufacturer's ID is located in address 00000H and the device ID is located in address 00001H. Once the device ID output data toggles between address 00000H and 00001H until terminated by a low-to-high transition on CE#.

Refer to Table 4-5 and Table 4-6 for device identification data.





# TABLE 4-6: PRODUCT IDENTIFICATION

	Address	Data
Manufacturer's ID	00000H	BFH
Device ID		
SST25VF080B	00001H	8EH

# 5.0 ELECTRICAL SPECIFICATIONS

# Absolute Maximum Ratings (†)

Temperature under bias	55°C to +125°C
Storage temperature	65°C to +150°C
DC voltage on any pin to ground potential	-0.5V to VDD+0.5V
Transient voltage (<20 ns) on any pin to ground potential	-2.0V to VDD+2.0V
Package power dissipation capability (TA = 25°C)	1.0W
Surface mount solder reflow temperature	
Output short circuit current <sup>(1)</sup>	

**† NOTICE:** Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Note 1:** Output shorted for no more than one second. No more than one output shorted at a time.

# TABLE 5-1: OPERATING RANGE

Range	Ambient Temp.	VDD
Commercial	0°C to +70°C	2.7V-3.6V
Industrial	-40°C to +85°C	2.1 0-3.00

# TABLE 5-2: AC CONDITIONS OF TEST<sup>(1)</sup>

Input Rise/Fall Time	Output Load
5 ns	CL = 30 pF

Note 1: See Figure 5-2 and Figure 5-3.

# 5.1 Power-Up Specifications

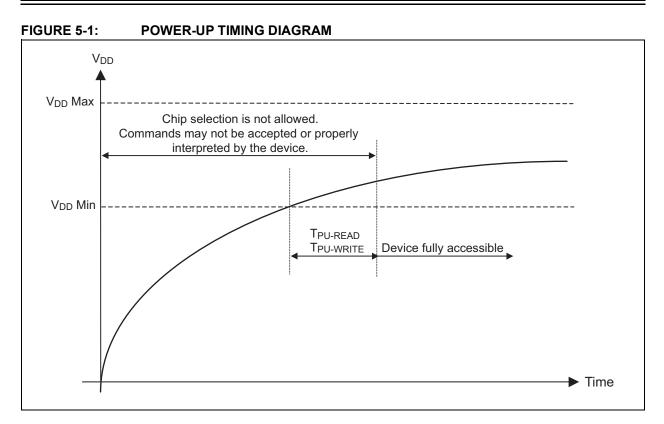
All functionalities and DC specifications are specified for a VDD ramp rate of greater than 1V per 100 ms (0V to 3.0V in less than 300 ms). See Table 5-3 and Figure 5-1 for more information.

#### TABLE 5-3: RECOMMENDED SYSTEM POWER-UP/POWER-DOWN TIMINGS

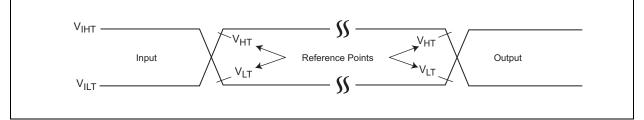
Symbol	Parameter	Min	Units
TPU-READ <sup>(1)</sup>	VDD Minimum to Read Operation	100	μs
TPU-WRITE <sup>(1)</sup>	VDD Minimum to Write Operation	100	μs

**Note 1:** This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

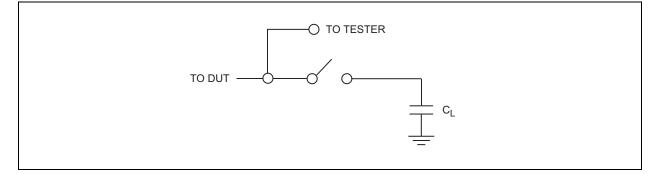
# SST25VF080B



# FIGURE 5-2: C INPUT/OUTPUT REFERENCE WAVEFORMS



# FIGURE 5-3: A TEST LOAD EXAMPLE



© 2005-2020 Microchip Technology Inc.

# 6.0 DC CHARACTERISTICS

		Limits			
Symbol	Parameter	Min.	Max.	Unit	Test Conditions
IDDR1	Read Current	—	10	mA	CE# = 0.1 VDD/0.9 VDD@25 MHz, SO = Open
IDDR2	Read Current	—	15	mA	CE# = 0.1 VDD/0.9 VDD@50 MHz, SO = Open
Iddw	Program and Erase Current	—	30	mA	CE# = VDD
ISB	Standby Current	—	30	μA	CE# = VDD, VIN = VDD or Vss
ILI	Input Leakage Current	—	1	μA	VIN = GND to VDD, VDD = VDD Max
Ilo	Output Leakage Current	_	1	μA	VOUT = GND to VDD, VDD = VDD Max
VIL	Input Low Voltage	—	0.8	V	Vdd = Vdd Min
Vih	Input High Voltage	0.7 Vdd	_	V	VDD = VDD Max
Vol1	Output Low Voltage	_	0.2	V	IOL = 100 μA, VDD = VDD Min
Vol2	Output Low Voltage	—	0.4	V	Iol = 1.6 mA, VDD = VDD Min
Vон	Output High Voltage	VDD-0.2	—	V	Іон = -100 µA, Vdd = Vdd Min

# TABLE 6-1: DC OPERATING CHARACTERISTICS

# TABLE 6-2:Capacitance (TA = 25°C, f = 1 MHz, Other Pins Open)

Parameter	Description	Test Condition	Maximum	
Cout <sup>(1)</sup>	Output Pin Capacitance	Vout = 0V	12 pF	
CIN <sup>(1)</sup>	Input Capacitance	VIN = 0V	6 pF	

**Note 1:** This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

TABLE 6-3:	RELIABILITY CHARACTERISTICS
------------	-----------------------------

Symbol	Parameter	eter Minimum Specification		Test Method
Nend <sup>(1)</sup>	Endurance	10,000	Cycles	JEDEC Standard A117
Tdr <sup>(1)</sup>	Data Retention	100	Years	JEDEC Standard A103
ILTH <sup>(1)</sup>	Latch Up	100 + Idd	mA	JEDEC Standard 78

**Note 1:** This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.

# 7.0 AC CHARACTERISTICS

# TABLE 7-1: AC OPERATING CHARACTERISTICS

0	Demonster	25 MHz		50 MHz		66 MHz <sup>(1,2)</sup>		11
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	- Units
Fclk <sup>(3)</sup>	Serial Clock Frequency		25		50		66	MHz
Тѕскн	Serial Clock High Time	18	_	9	_	7	_	ns
TSCKL	Serial Clock Low Time	18	—	9	_	7	_	ns
TSCKR <sup>(4)</sup>	Serial Clock Rise Time (slew rate)	0.1	_	0.1	_	0.1	_	V/ns
TSCKF	Serial Clock Fall Time (slew rate)	0.1	_	0.1	_	0.1	_	V/ns
TCES <sup>(5)</sup>	CE# Active Setup Time	10	_	5	_	4	_	ns
TCEH <sup>(5)</sup>	CE# Active Hold Time	10	_	5	_	4	_	ns
TCHS <sup>(5)</sup>	CE# Not Active Setup Time	10	_	5	_	4	_	ns
Тснн <sup>(5)</sup>	CE# Not Active Hold Time	10	_	5	_	4	_	ns
Тсрн	CE# High Time	100	_	50	_	100	_	ns
Тснz	CE# High-to-High Z Output	_	15	_	8	_	6	ns
TCLZ	SCK Low-to-Low Z Output	0	_	0	_	0	_	ns
TDS	Data In Setup Time	5	—	2	_	2	_	ns
Тон	Data In Hold Time	5	_	5	_	3	_	ns
THLS	HOLD# Low Setup Time	10	—	5	_	4	_	ns
THHS	HOLD# High Setup Time	10	_	5	_	4	_	ns
THLH	HOLD# Low Hold Time	10	_	5	_	4	_	ns
Тннн	HOLD# High Hold Time	10	—	5	_	4	_	ns
Тнz	HOLD# Low-to-High Z Output	_	20	_	8	—	8	ns
TLZ	HOLD# High-to-Low Z Output		15	_	8	_	8	ns
Тон	Output Hold from SCK Change	0	—	0	_	0	_	ns
Τv	Output Valid from SCK		15		8		6	ns
TSE	Sector Erase		25		25		25	ms
Тве	Block Erase		25		25		25	ms
TSCE	Chip Erase		50		50		50	ms
Твр	Byte Program		10	_	10	_	10	μs

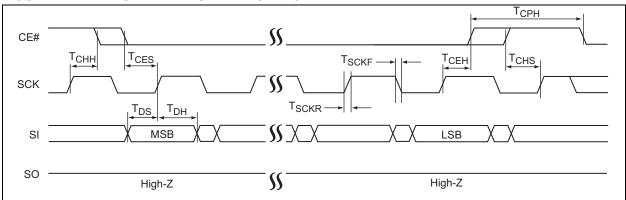
Note 1: VDD = 3.0V to 3.6V, CL = 15 pF.

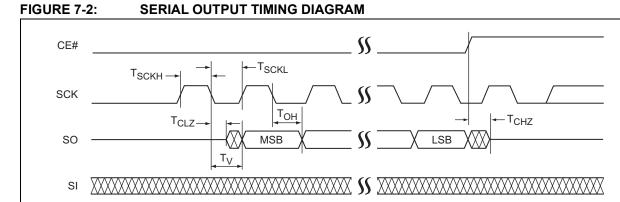
2: Characterized, but not fully tested.

- 3: Maximum clock frequency for Read Instruction, 03H, is 25 MHz.
- 4: Maximum Rise and Fall time may be limited by TSCKH and TSCKL requirements.
- 5: Relative to SCK.

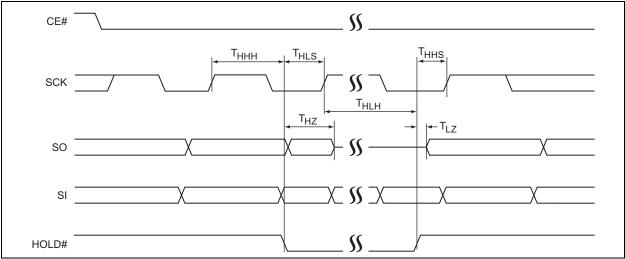
# SST25VF080B





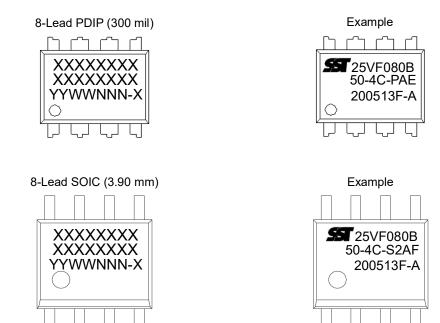






# 8.0 PACKAGING INFORMATION

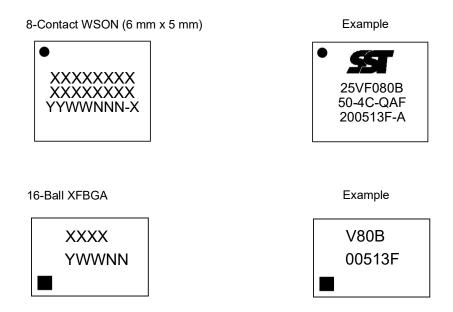
# 8.1 Package Marking Information



Legend	: XXX Y YY WW NNN @3	Part number or part number code Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code (2 characters for small packages) Pb-free JEDEC <sup>®</sup> designator for Matte Tin (Sn)
Note:		small packages with no room for the Pb-free JEDEC <sup>®</sup> designator narking will only appear on the outer carton or reel label.
Note:	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

© 2005-2020 Microchip Technology Inc.

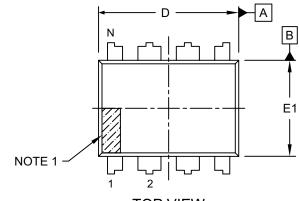
# Package Marking Information (Continued)



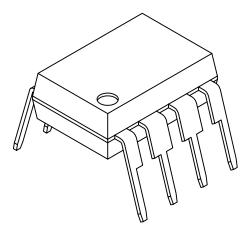
Part Number	1 <sup>st</sup> Line Marking Codes           PDIP         SOIC         WDFN         XFBGA					
Fart Number						
SST25VF080B	25VF080B	25VF080B	25VF080B	25VF080B		

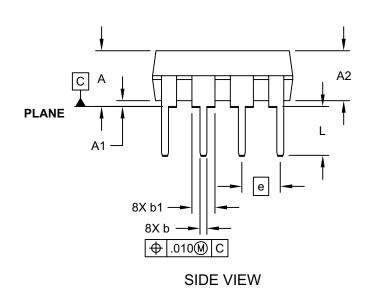
# 8-Lead Plastic Dual In-Line (P) - 300 mil Body [PDIP]

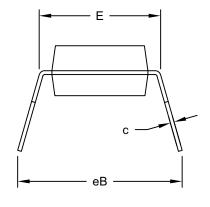
**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging









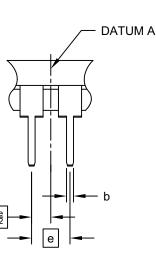


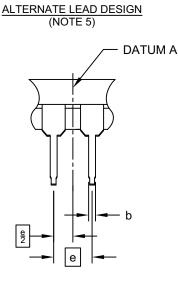
END VIEW

Microchip Technology Drawing No. C04-018-P Rev E Sheet 1 of 2

# 8-Lead Plastic Dual In-Line (P) - 300 mil Body [PDIP]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging





		INCHES		
Dimensior	Dimension Limits			MAX
Number of Pins	N		8	
Pitch	е		.100 BSC	
Top to Seating Plane	Α	-	-	.210
Molded Package Thickness	A2	.115	.130	.195
Base to Seating Plane	A1	.015	-	-
Shoulder to Shoulder Width	E	.290	.310	.325
Molded Package Width	E1	.240 .250 .280		
Overall Length	D	.348	.365	.400
Tip to Seating Plane	L	.115	.130	.150
Lead Thickness	С	.008	.010	.015
Upper Lead Width	b1	.040	.060	.070
Lower Lead Width	b	.014	.018	.022
Overall Row Spacing §	eB	-	-	.430

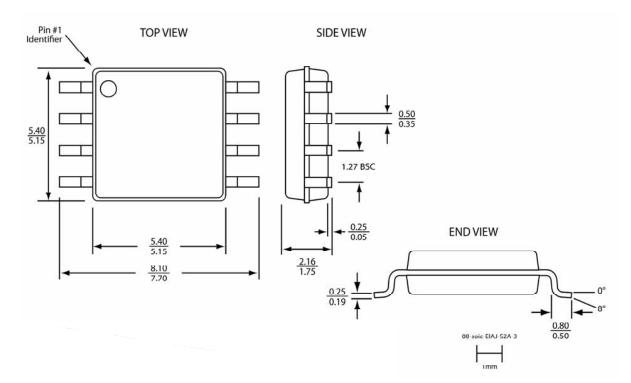
Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. § Significant Characteristic
- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M BSC: Basic Dimension. Theoretically exact value shown without tolerances.
- 5. Lead design above seating plane may vary, based on assembly vendor.

Microchip Technology Drawing No. C04-018-P Rev E Sheet 2 of 2

# 8-Lead Small Outline Integrated Circuit (S2AE/F) - .208 Inch Body [SOIC]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



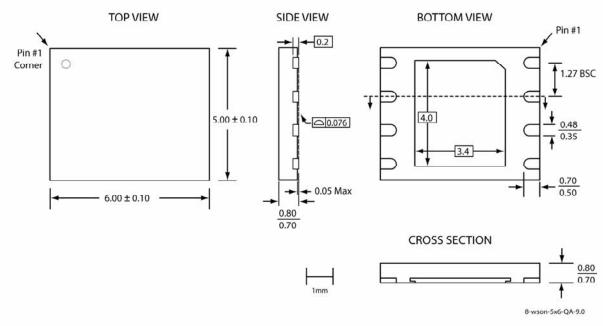
#### Note:

- 1. All linear dimensions are in millimeters (max/min).
- 2. Coplanarity: 0.1 mm
- 3. Maximum allowable mold flash is 0.15 mm at the package ends and 0.25 mm between leads.

Microchip Technology Drawing C04-14005A Sheet 1 of 1

# 8-Lead Very, Very Thin Small Outline No-Leads (QAE/F) - 5x6 mm Body [WSON]

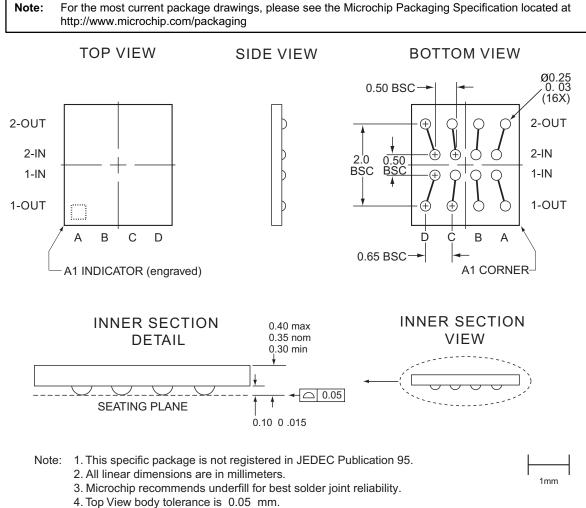
**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Note:

- 1. All linear dimensions are in millimeters (max/min).
- 2. Untoleranced dimensions (shown with box surround) are nominal target dimensions.
- The external paddle is electrically connected to the die back-side and possibly to certain VSS leads. This paddle can be soldered to the PC board; it is suggested to connect this paddle to the VSS of the unit. Connection of this paddle to any other voltage potential can result in shorts and/or electrical malfunction of the device.

Microchip Technology Drawing C04-14008A Sheet 1 of 1



# 16-bump Super-thin-profile, Fine-pitch, Ball Grid Array [XFBGA]

5. Coplanarity is 0.05 mm.

6. Ball width at interface to package body is 0.25 mm (0. 03 mm).

16-xfbga-ZC Z1 C-25VF080B-018

# 9.0 REVISION HISTORY

# **Revision D (March 2020)**

Updated standby current. Updated formatting to current template. Updated package drawings to latest versions. Added package marking section. Updated Product Identification System Nickel plating note. Added 16-ball XFBGA package.

# Revision C (February 2015)

Corrected a typo on page 8.

# Revision B (June 2014)

EOL of all 80 MHz parts. Replacement parts are the 50 MHz counterparts found in this document. Removed all 80 MHz information. See DS20005266. EOL of SAE package. Updated document to new format. Replaced all package drawings with drawings in the new format.

# **Revision A (September 2011)**

Added "Power-Up Specifications" on page 21. Updated Table 5-7 on page 21. Released document under letter revision system. Updated Spec number from S71296 to DS25045.

# Revision 05 (February 2011)

Updated "Auto Address Increment (AAI) Word-Program", "End of Write Detection", and "Hardware End of Write Detection" on page 10. Revised Figures 4-8 and 4-9 on page 11. Updated document to new format. Added SAE package drawing and SAE information.

# Revision 04 (January 2010)

Added 80 MHz High Speed Clock Frequency to Features. Removed Maximum Frequency from Table 4-4 on page 7. Edited "Read (25 MHz)" on page 8 and "High-Speed-Read (66 MHz)" on page 8. Added 80 MHz information to "Electrical Specifications" on page 18. Edited Product Ordering Information. Added Valid Combinations SST25VF080B-80-4C-S2AE, SST25VF080B-80-4I-S2AE, SST25VF080B-80-4I-S2AE, SST25VF080B-80-4I-QAE, and SST25VF080B-80-4I-QAE.

# Revision 03 (March 2009)

Modified "Features", "Features", "Pin Description", "Packaging Diagrams" and "Packaging Diagrams" to include the PAE package. Updated Figures 4-8 and 4-9 on page 11.

# Revision 02 (June 2007)

Updated Features. Updated Table 4-4 on page 7. Updated "High-Speed-Read (66 MHz)" on page 8. Updated Table 5-6 on page 19.

# Revision 01 (January 2006)

Migrated document to a Data Sheet. Updated Surface Mount Solder Reflow Temperature information.

# **Revision 00 (September 2005)**

Initial release of the document

# THE MICROCHIP WEBSITE

Microchip provides online support via our website at www.microchip.com. This website is used as a means to make files and information easily available to customers. Accessible by using your favorite Internet browser, the website contains the following information:

- Product Support Data sheets and errata, application notes and sample programs, design resources, user's guides and hardware support documents, latest software releases and archived software
- General Technical Support Frequently Asked Questions (FAQ), technical support requests, online discussion groups, Microchip consultant program member listing
- Business of Microchip Product selector and ordering guides, latest Microchip press releases, listing of seminars and events, listings of Microchip sales offices, distributors and factory representatives

# CUSTOMER CHANGE NOTIFICATION SERVICE

Microchip's customer notification service helps keep customers current on Microchip products. Subscribers will receive e-mail notification whenever there are changes, updates, revisions or errata related to a specified product family or development tool of interest.

To register, access the Microchip website at www.microchip.com. Under "Support", click on "Customer Change Notification" and follow the registration instructions.

# **CUSTOMER SUPPORT**

Users of Microchip products can receive assistance through several channels:

- Distributor or Representative
- Local Sales Office
- Field Application Engineer (FAE)
- Technical Support

Customers should contact their distributor, representative or Field Application Engineer (FAE) for support. Local sales offices are also available to help customers. A listing of sales offices and locations is included in the back of this document.

Technical support is available through the website at: http://microchip.com/support

# **PRODUCT IDENTIFICATION SYSTEM**

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

•	erating Mini	– <u>XX</u> imum Temp Pa irance Range		nvironmental Attribute	-[X] <sup>(1)</sup> Tape and Reel Indicator	a) b) c)	SST25V SST25VI SST25V	inations: F080B-50-4C-S2AF F080B-50-4C-S2AF-T F080B-50-4I-S2AF F080B-50-4I-S2AF-T
Device:	SST25VF080B	VF080B = 8 Mbit, 2.7V-3.6V, SPI Flash Memory				f)	SST25VF080B-50-4I-S2AE SST25VF080B-50-4I-S2AE-T SST25VF080B-50-4C-QAF	
Operating Frequency:	50	= 50 MHz/66 MHz				b) i) j)	SST25V SST25V SST25V	F080B-50-4C-QAF-T F080B-50-4I-QAF F080B-50-4I-QAF-T
Minimum Endurance:	4	= 10,000 cycles				l) m)	SST25V SST25V	F080B-50-4I-QAE F080B-50-4I-QAE-T F080B-50-4C-PAE F080B-50-4I-ZCE
Temperature Range:	l C	= -40°C to +85°C (I = 0°C to +70°C (Co				No	ote 1:	Tape and Reel identi- fier only appears in
Package:	P S2 Q Z							the catalog part num- ber description. This identifier is used for ordering purposes and is not printed on the device package.
Package Modifier:	A C	<ul><li>8 leads or conta</li><li>16 bumps</li></ul>	icts					Check with your Microchip Sales Office for package availability with the
Environmental Attribute:	E F	<ul><li>Matte Tin finish</li><li>Nickel plating w</li></ul>	ith Gold top (outer) l	ayer finish or Mat	te Tin finish			Tape and Reel option.
Tape and Reel Indicator:	Blank T	<ul> <li>Standard packa</li> <li>Tape and Reel<sup>(</sup></li> </ul>	ging (tube or tray)					

#### Note the following details of the code protection feature on Microchip devices:

- · Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

# For information regarding Microchip's Quality Management Systems, please visit www.microchip.com/quality.

#### Trademarks

The Microchip name and logo, the Microchip logo, Adaptec, AnyRate, AVR, AVR logo, AVR Freaks, BesTime, BitCloud, chipKIT, chipKIT logo, CryptoMemory, CryptoRF, dsPIC, FlashFlex, flexPWR, HELDO, IGLOO, JukeBlox, KeeLoq, Kleer, LANCheck, LinkMD, maXStylus, maXTouch, MediaLB, megaAVR, Microsemi, Microsemi logo, MOST, MOST logo, MPLAB, OptoLyzer, PackeTime, PIC, picoPower, PICSTART, PIC32 logo, PolarFire, Prochip Designer, QTouch, SAM-BA, SenGenuity, SpyNIC, SST, SST Logo, SuperFlash, Symmetricom, SyncServer, Tachyon, TempTrackr, TimeSource, tinyAVR, UNI/O, Vectron, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

APT, ClockWorks, The Embedded Control Solutions Company, EtherSynch, FlashTec, Hyper Speed Control, HyperLight Load, IntelliMOS, Libero, motorBench, mTouch, Powermite 3, Precision Edge, ProASIC, ProASIC Plus, ProASIC Plus logo, Quiet-Wire, SmartFusion, SyncWorld, Temux, TimeCesium, TimeHub, TimePictra, TimeProvider, Vite, WinPath, and ZL are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, AnyIn, AnyOut, BlueSky, BodyCom, CodeGuard, CryptoAuthentication, CryptoAutomotive, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, EtherGREEN, In-Circuit Serial Programming, ICSP, INICnet, Inter-Chip Connectivity, JitterBlocker, KleerNet, KleerNet Iogo, memBrain, Mindi, MiWi, MPASM, MPF, MPLAB Certified Iogo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PowerSmart, PureSilicon, QMatrix, REAL ICE, Ripple Blocker, SAM-ICE, Serial Quad I/O, SMART-I.S., SQI, SuperSwitcher, SuperSwitcher II, Total Endurance, TSHARC, USBCheck, VariSense, ViewSpan, WiperLock, Wireless DNA, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

The Adaptec logo, Frequency on Demand, Silicon Storage Technology, and Symmcom are registered trademarks of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2005-2020, Microchip Technology Incorporated, All Rights Reserved.

ISBN: 978-1-5224-5861-6



# Worldwide Sales and Service

#### AMERICAS

**Corporate Office** 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://www.microchip.com/ support

Web Address: www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

**Boston** Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI Tel: 248-848-4000

Houston, TX Tel: 281-894-5983

Indianapolis Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453 Tel: 317-536-2380

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608 Tel: 951-273-7800

Raleigh, NC Tel: 919-844-7510

New York, NY Tel: 631-435-6000

San Jose, CA Tel: 408-735-9110 Tel: 408-436-4270

Canada - Toronto Tel: 905-695-1980 Fax: 905-695-2078

#### ASIA/PACIFIC

Australia - Sydney Tel: 61-2-9868-6733

China - Beijing Tel: 86-10-8569-7000 China - Chengdu

Tel: 86-28-8665-5511 China - Chongqing Tel: 86-23-8980-9588

China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

China - Hangzhou Tel: 86-571-8792-8115

China - Hong Kong SAR Tel: 852-2943-5100

China - Nanjing Tel: 86-25-8473-2460

China - Qingdao Tel: 86-532-8502-7355

China - Shanghai Tel: 86-21-3326-8000

China - Shenyang Tel: 86-24-2334-2829

China - Shenzhen Tel: 86-755-8864-2200

China - Suzhou Tel: 86-186-6233-1526

China - Wuhan Tel: 86-27-5980-5300

China - Xian Tel: 86-29-8833-7252

China - Xiamen Tel: 86-592-2388138 China - Zhuhai

Tel: 86-756-3210040

# ASIA/PACIFIC

India - Bangalore Tel: 91-80-3090-4444

India - New Delhi Tel: 91-11-4160-8631

Tel: 91-20-4121-0141 Japan - Osaka

Tel: 81-6-6152-7160 Japan - Tokyo

Tel: 81-3-6880- 3770 Korea - Daegu

Tel: 82-53-744-4301 Korea - Seoul

Tel: 82-2-554-7200

Malaysia - Kuala Lumpur Tel: 60-3-7651-7906

Malaysia - Penang Tel: 60-4-227-8870

Philippines - Manila Tel: 63-2-634-9065

Singapore Tel: 65-6334-8870

Taiwan - Hsin Chu

Tel: 886-3-577-8366 Taiwan - Kaohsiung Tel: 886-7-213-7830

Taiwan - Taipei Tel: 886-2-2508-8600

Thailand - Bangkok

Vietnam - Ho Chi Minh Tel: 84-28-5448-2100

Fax: 31-416-690340

EUROPE

Austria - Wels

Tel: 43-7242-2244-39

Tel: 45-4485-5910

Fax: 45-4485-2829

Tel: 358-9-4520-820

Tel: 33-1-69-53-63-20

Fax: 33-1-69-30-90-79

**Germany - Garching** 

Tel: 49-2129-3766400

Germany - Heilbronn

Germany - Karlsruhe

Tel: 49-7131-72400

Tel: 49-721-625370

Germany - Munich

Tel: 49-89-627-144-0

Fax: 49-89-627-144-44

Germany - Rosenheim

Tel: 49-8031-354-560

Israel - Ra'anana

Italy - Milan

Italy - Padova

Tel: 972-9-744-7705

Tel: 39-0331-742611

Fax: 39-0331-466781

Tel: 39-049-7625286

Tel: 49-8931-9700

Germany - Haan

Finland - Espoo

France - Paris

Fax: 43-7242-2244-393

**Denmark - Copenhagen** 

Tel: 48-22-3325737

Tel: 40-21-407-87-50

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Gothenberg Tel: 46-31-704-60-40

Sweden - Stockholm Tel: 46-8-5090-4654

**UK - Wokingham** Tel: 44-118-921-5800 Fax: 44-118-921-5820

Tel: 66-2-694-1351

**Netherlands - Drunen** Tel: 31-416-690399

Norway - Trondheim Tel: 47-7288-4388

Poland - Warsaw

**Romania - Bucharest** 

# India - Pune

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for NOR Flash category:

Click to view products by Microchip manufacturer:

Other Similar products are found below :

AM29BL162CB-80RDPE1 AM29F800BT-90DPE 2 S29AL016J70BFI012 S29AL016J70FFI022 S29GL064N90BFI032 S29GL064N90BFI042 S29GL064N90FFI012 S29GL128P10FFI022 S29GL256P11FFIV12 S29GL256P11FFIV22 S29GL512S10GHI020 S70FL01GSAGMFV011 S99-50389 P AM29F016D-120DPI 1 AT25DF011-SSHN-T AT25DF011-XMHN-T AT25DF041B-MHN-Y AT25DN256-SSHF-T AT25DN512C-MAHF-T AT45DB161E-CCUD-T S29AL008J55BFIR22 S29GL032N90TFI033 S29GL032N90TFI043 S29GL256P11FFI012 S29JL064J55TFI003 S70FL01GSAGMFI013 S99-50052 S29AL008J55BFIR23 M29W128GL70ZS3F PC28F128J3F75B S29GL128P10TFI013 S29GL064N90FFI022 S29GL032N11FFIS12 S29AL016D90DGI027 S29JL032J70TFI423 S29GL128S10TFIV13 S29AL016J70WEI029 S25FL132K0XMFB043 AT25DF041B-SSHNHR-T S25FL116K0XNFB010 S25FL132K0XBHA020 AT25SL321-MBUE-T SST39VF800A-70-4I-MAQE LE25S40MB-AH S25FL116K0XNFA013 SST39VF400A-70-4C-MAQE AT25DF512C-XMHN-T S25FL256LAGMFI001 S26KL128SDABHN020 520366231286